

**Notice of References Cited**

Application/Control No.

10/561,807

Applicant(s)/Patent Under  
Reexamination  
LEE, DEOK-JAE

Examiner

Mohammad M. Ali

Art Unit

3744

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,776,029	08-2004	Hotta et al.	73/61.41
*	B	US-5,884,494	03-1999	Okoren et al.	62/126
*	C	US-4,866,994	09-1989	Baker, James A.	73/863.12
*	D	US-3,705,499	12-1972	Mount et al.	62/84
*	E	US-5,401,149	03-1995	Tsuru et al.	418/178
*	F	US-5,086,630	02-1992	Van Steenburgh, Jr., Leon R.	62/475
*	G	US-4,982,576	01-1991	Proctor et al.	62/292
*	H	US-5,133,880	07-1992	Lundquist et al.	210/774
*	I	US-4,625,523	12-1986	Toub et al.	62/193
*	J	US-4,534,182	08-1985	Toub et al.	62/193
*	K	US-5,678,657	10-1997	Lee, Sung-Jae	184/6.16
*	L	US-4,698,983	10-1987	Hechavarria, Ruben	62/292
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003-21611 A	01-2003	Japan	Hotta et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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